

Page 1 of 1	Atty. Docket No.: H0004978(1100.1206101)	Serial No.: 10/671,930
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	Applicant: Ulrich Bonne	
	Filing Date: September 26, 2003	Group Art: unknown

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	
KAM	4,324,566	04/1982	Jacob et al.	
KAM	5,196,039	03/1991	Phillips et al.	
KAM	5,442,175	08/1995	Dawson	
KAM	6,131,440	10/2000	Bertrand	
KAM	6,413,781	07/2002	Geis et al.	


FOREIGN PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Country	Translation Yes No

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER: <i>Beri D...</i>	DATE CONSIDERED: <i>1/13/06</i>

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U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	
KAM	5,135,549	08/04/1992	Phillips et al.	<u> </u>
KAM	6,169,965	01/02/2001	Kubisiak et al.	<u> </u>


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Examiner Initial	Document No.	Date	Country	Translation Yes No
KAM	WO 00/61261	10/19/2000	PCT	<u> </u>

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER: <u>KAM</u>	DATE CONSIDERED: <u>11/13/06</u>

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KAM	3,146,616	09/1964	Loyd			
KAM	3,557,532	01/1971	Broerman			
KAM	3,783,356	01/1974	Lide, III et al.			
KAM	4,043,196	08/1977	Trageser			
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KAM	6,016,027	01/2000	DeTemple et al.			
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KAM	DE 32 34 146 A1	03/15/84	Germany	
KAM	DE 42 22 458 A1	01/13/94	Germany	Abstract
KAM	DE 42 43 573 A1	06/23/94	Germany	
KAM	DE 296 07 315 U1	09/26/96	Germany	
KAM	EP 0 232 719 A1	01/10/87	Europe	Abstract
KAM	EP 0 348 245 A2	12/27/89	Europe	
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KAM	EP 0 773 432 A2	05/14/97	Europe	Abstract
KAM	GB 2 287 792 A	09/1995	United Kingdom	
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KAM	57-206830	12/1982	Japan	Abstract
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